

<b>Notice of References Cited</b>	Application/Control No. 10/566,224		Applicant(s)/Patent Under Reexamination FUJII ET AL.	
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#### U.S. PATENT DOCUMENTS

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#### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

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	U	Tettelin et al Science 293, 498-506, 2001			
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